

General Description

The AOD609G uses advanced trench technology MOSFETs to provide excellent $R_{DS(ON)}$ and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications.

- RoHS Compliant
- Halogen Free*

Features

n-channel

V_{DS} (V) = 40V, I_D = 12A ($V_{GS}=10V$)

$R_{DS(ON)} < 30m\Omega$ ($V_{GS}=10V$)

$R_{DS(ON)} < 40m\Omega$ ($V_{GS}=4.5V$)

p-channel

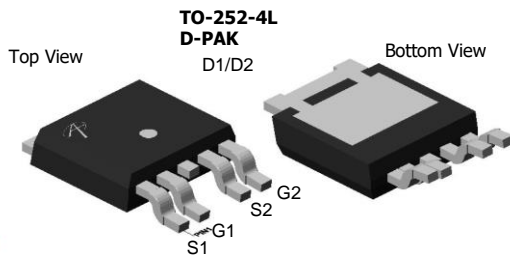
V_{DS} (V) = -40V, I_D = -12A ($V_{GS}=-10V$)

$R_{DS(ON)} < 45m\Omega$ ($V_{GS}= -10V$)

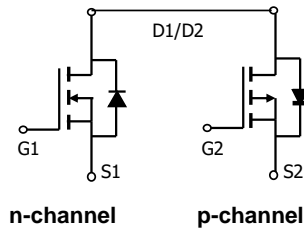
$R_{DS(ON)} < 66m\Omega$ ($V_{GS}= -4.5V$)

100% UIS Tested!

100% Rg Tested!



Top View
Drain Connected to Tab



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Max n-channel | Max p-channel | Units |
|---|-------------------------|---------------|---------------|------------------|
| Drain-Source Voltage | V_{DS} | 40 | -40 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | ± 20 | V |
| Continuous Drain Current ^{B,G} | $T_C=25^\circ\text{C}$ | 12 | -12 | A |
| | $T_C=100^\circ\text{C}$ | 12 | -12 | |
| Pulsed Drain Current ^B | I_{DM} | 30 | -30 | |
| Avalanche Current ^C | I_{AR} | 14 | -20 | |
| Repetitive avalanche energy $L=0.1\text{mH}$ ^C | E_{AR} | 9.8 | 20 | mJ |
| Power Dissipation | $T_C=25^\circ\text{C}$ | 27 | 30 | W |
| | $T_C=100^\circ\text{C}$ | 14 | 15 | |
| Power Dissipation | $T_A=25^\circ\text{C}$ | 2 | 2 | W |
| | $T_A=70^\circ\text{C}$ | 1.3 | 1.3 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 175 | -55 to 175 | $^\circ\text{C}$ |

Thermal Characteristics: n-channel and p-channel

| Parameter | Symbol | Device | Typ | Max | Units |
|--|-----------------|--------|------|-----|--------------------|
| Maximum Junction-to-Ambient ^{A,D} | $R_{\theta JA}$ | n-ch | 17.4 | 25 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^{A,D} | | | | | |
| Maximum Junction-to-Case | $R_{\theta JC}$ | n-ch | 4 | 5.5 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^{A,D} | | | | | |
| Maximum Junction-to-Ambient ^{A,D} | $R_{\theta JA}$ | p-ch | 16.7 | 25 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^{A,D} | | | | | |
| Maximum Junction-to-Case | $R_{\theta JC}$ | p-ch | 3.5 | 5 | $^\circ\text{C/W}$ |

N Channel Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|----------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 40 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =40V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} = ±20V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 1.7 | 2.5 | 3 | V |
| I _{D(ON)} | On state drain current | V _{GS} =10V, V _{DS} =5V | 30 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =12A T _J =125°C | | 24 37 | 30 46 | mΩ |
| | | V _{GS} =4.5V, I _D =8A | | 31 | 40 | |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =12A | | 25 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.76 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 12 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =20V, f=1MHz | | 545 | | pF |
| C _{oss} | Output Capacitance | | | 65 | | pF |
| C _{rfs} | Reverse Transfer Capacitance | | | 40 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 1.6 | 3.2 | 4.8 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g (10V) | Total Gate Charge | V _{GS} =10V, V _{DS} =20V, I _D =12A | | 10 | 13 | nC |
| Q _{gs} | Gate Source Charge | | | 2 | | nC |
| Q _{gd} | Gate Drain Charge | | | 2.2 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =20V, R _L =1.4Ω, R _{GEN} =3Ω | | 5.5 | | ns |
| t _r | Turn-On Rise Time | | | 3 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 19 | | ns |
| t _f | Turn-Off Fall Time | | | 4 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =12A, di/dt=100A/μs | | 13 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =12A, di/dt=100A/μs | | 6.5 | | nC |

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{θJA} t_s ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

*This device is guaranteed green after data code 8X11 (Sep 1ST 2008).

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P-Channel Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units | |
|-----------------------------|---------------------------------------|---|------|-------|------|-------|----|
| STATIC PARAMETERS | | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D = -250μA, V _{GS} =0V | -40 | | | V | |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -40V, V _{GS} =0V | | | -1 | μA | |
| | | T _J =55°C | | | -5 | | |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} = ±20V | | | ±100 | nA | |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} I _D = -250μA | -1.7 | -2 | -3 | V | |
| I _{D(ON)} | On state drain current | V _{GS} = -10V, V _{DS} = -5V | -30 | | | A | |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} = -10V, I _D = -12A | | 36 | 45 | mΩ | |
| | | T _J =125°C | | 52 | 65 | | |
| | | V _{GS} = -4.5V, I _D = -8A | | 51 | 66 | | |
| g _{FS} | Forward Transconductance | V _{DS} = -5V, I _D = -12A | | 22 | | S | |
| V _{SD} | Diode Forward Voltage | I _S = -1A, V _{GS} =0V | | -0.76 | -1 | V | |
| I _S | Maximum Body-Diode Continuous Current | | | | -12 | A | |
| DYNAMIC PARAMETERS | | | | | | | |
| C _{ISS} | Input Capacitance | V _{GS} =0V, V _{DS} = -20V, f=1MHz | | 890 | | pF | |
| C _{OSS} | Output Capacitance | | | | 90 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | | 60 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 6.5 | 13 | 19.5 | Ω | |
| SWITCHING PARAMETERS | | | | | | | |
| Q _g (-10V) | Total Gate Charge | V _{GS} = -10V, V _{DS} = -20V, I _D = -12A | | 15.5 | 21 | nC | |
| Q _g (-4.5V) | Total Gate Charge | | | 7 | 9 | nC | |
| Q _{gs} | Gate Source Charge | | | 3.2 | | nC | |
| Q _{gd} | Gate Drain Charge | | | 3.5 | | nC | |
| t _{D(on)} | Turn-On DelayTime | V _{GS} = -10V, V _{DS} = -20V, R _L =1.4Ω, R _{GEN} =3Ω | | 10 | | ns | |
| t _r | Turn-On Rise Time | | | 15.5 | | ns | |
| t _{D(off)} | Turn-Off DelayTime | | | 35 | | ns | |
| t _f | Turn-Off Fall Time | | | 50 | | ns | |
| t _{rr} | Body Diode Reverse Recovery Time | I _F = -12A, dI/dt=100A/μs | | 20 | | ns | |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F = -12A, dI/dt=100A/μs | | 11 | | nC | |

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} ≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CANNEL

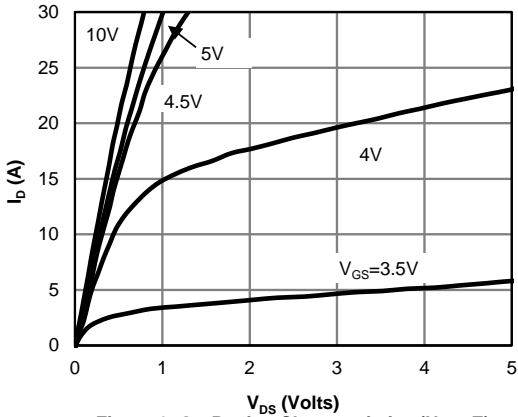


Figure 1: On-Region Characteristics (Note E)

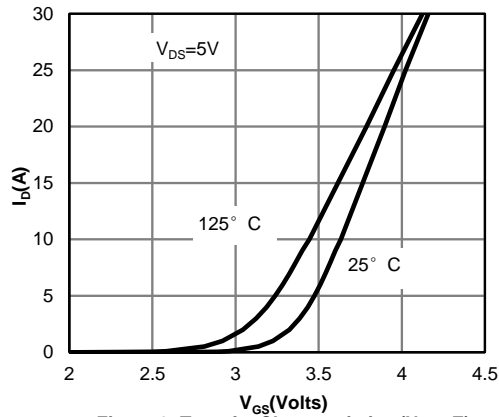


Figure 2: Transfer Characteristics (Note E)

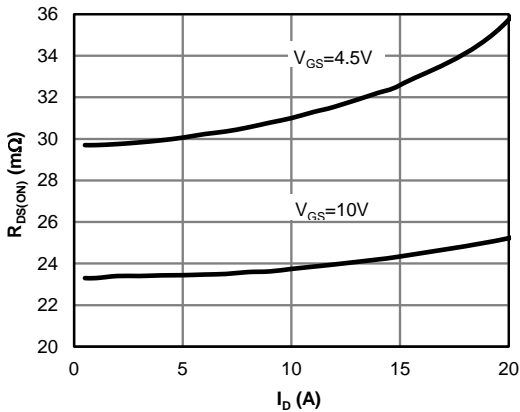


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

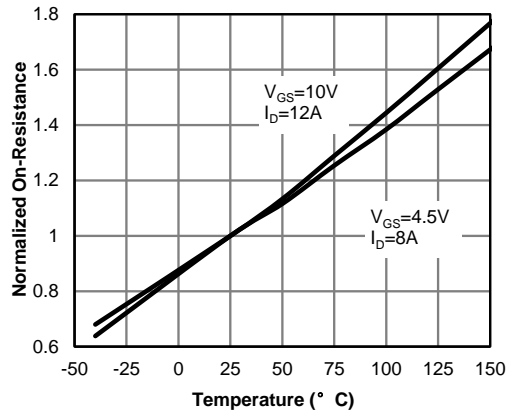


Figure 4: On-Resistance vs. Junction Temperature (Note E)

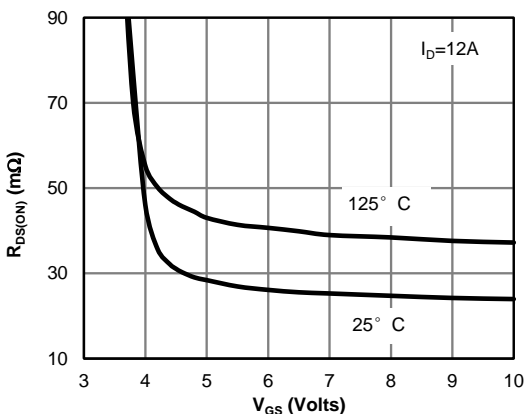


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

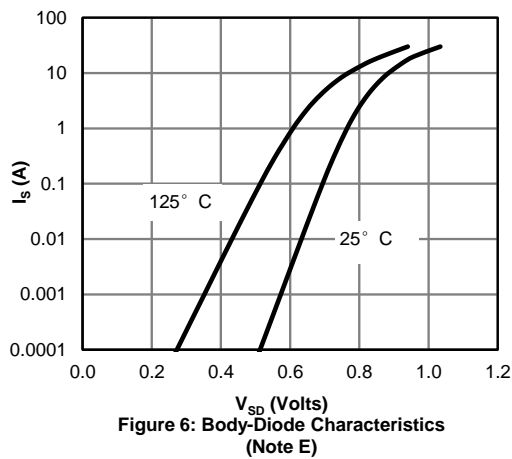


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

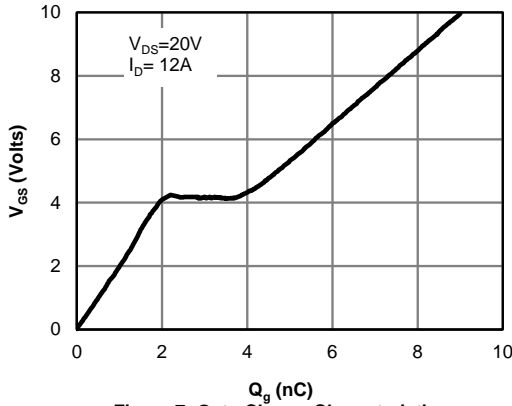


Figure 7: Gate-Charge Characteristics

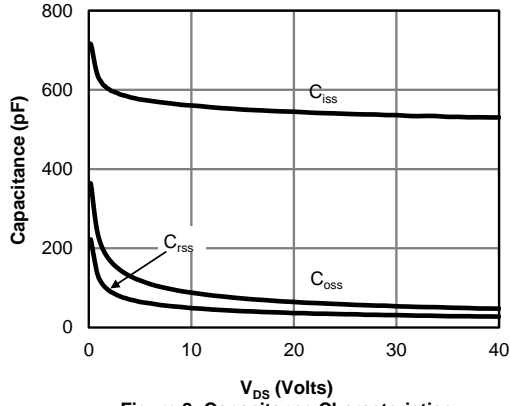


Figure 8: Capacitance Characteristics

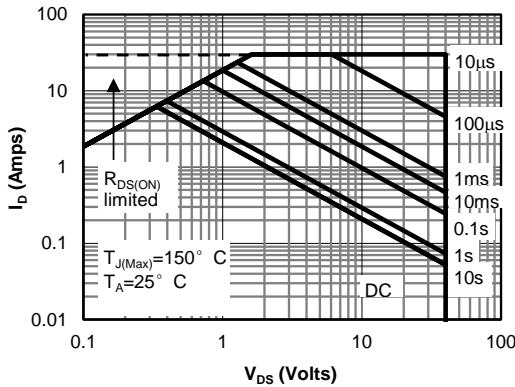


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

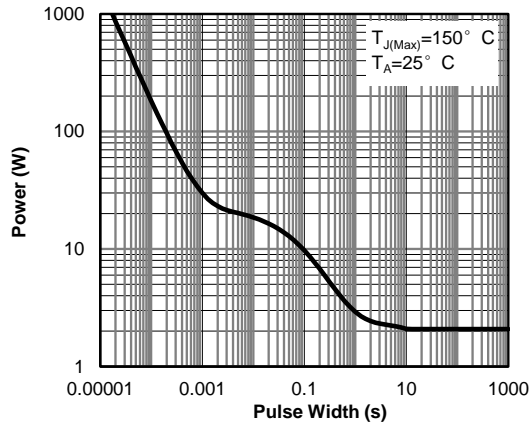


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note H)

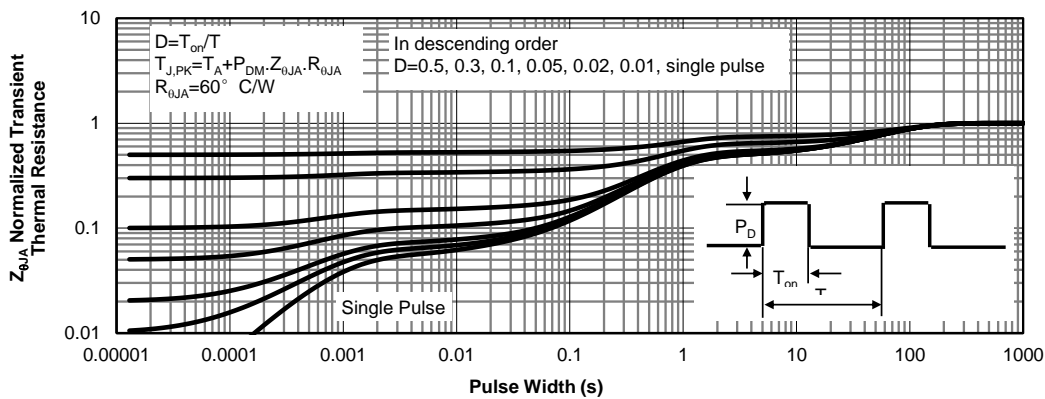
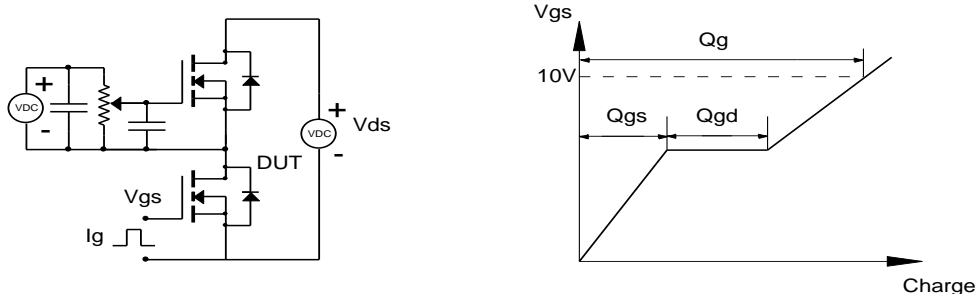


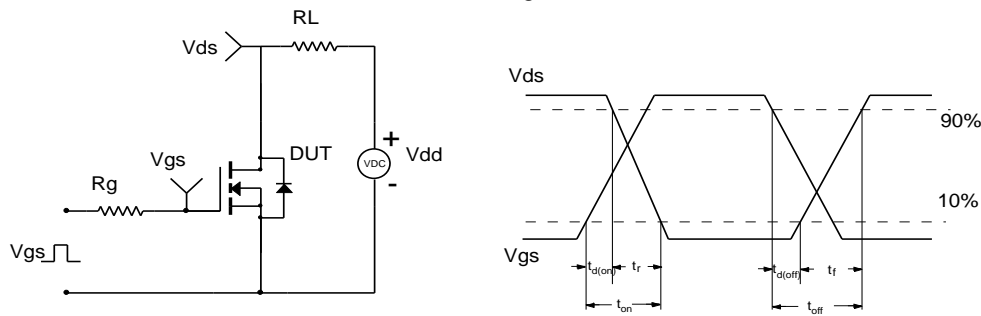
Figure 11: Normalized Maximum Transient Thermal Impedance (Note H)

TEST CIRCUITS AND WAVEFORMS: N-CHANNEL

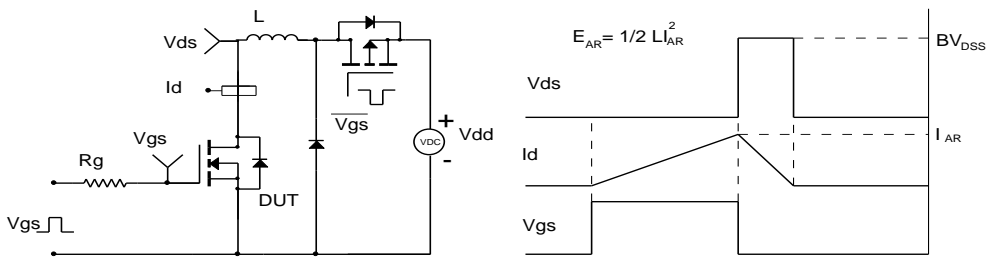
Gate Charge Test Circuit & Waveform



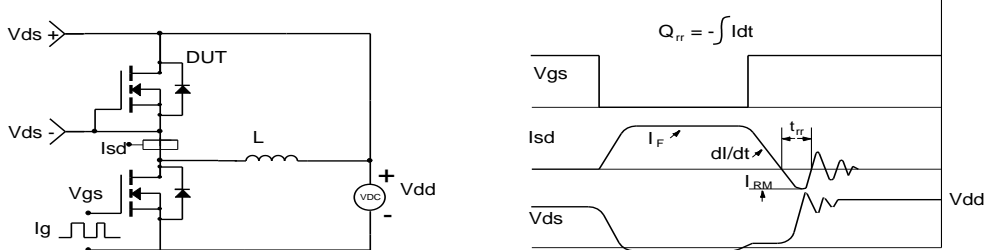
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

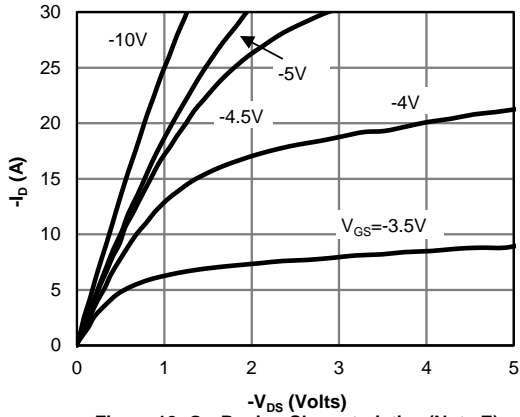


Figure 12: On-Region Characteristics (Note E)

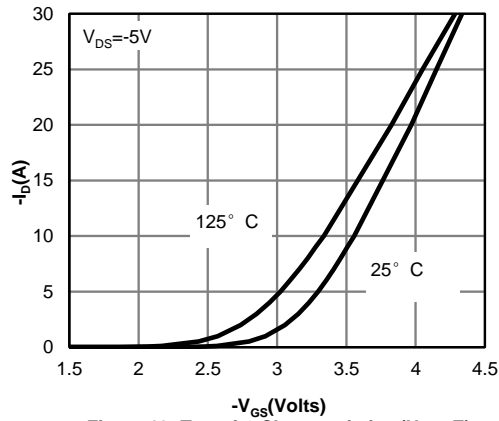


Figure 13: Transfer Characteristics (Note E)

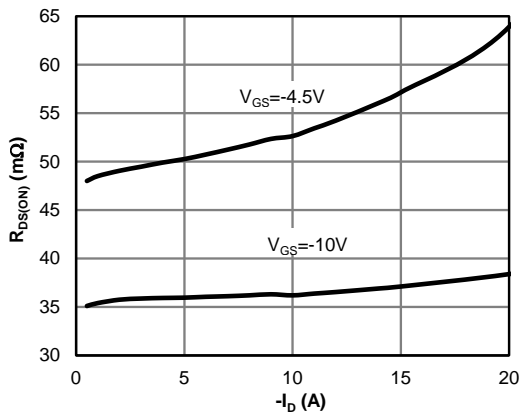


Figure 14: On-Resistance vs. Drain Current and Gate Voltage (Note E)

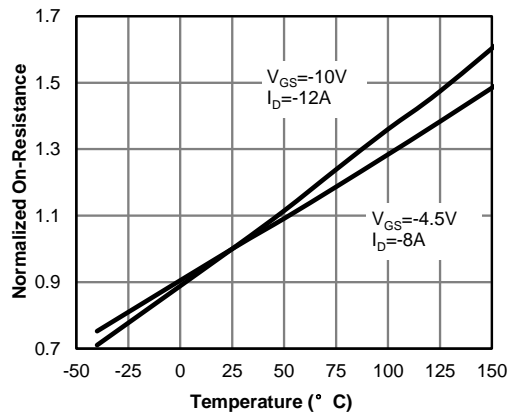


Figure 15: On-Resistance vs. Junction Temperature (Note E)

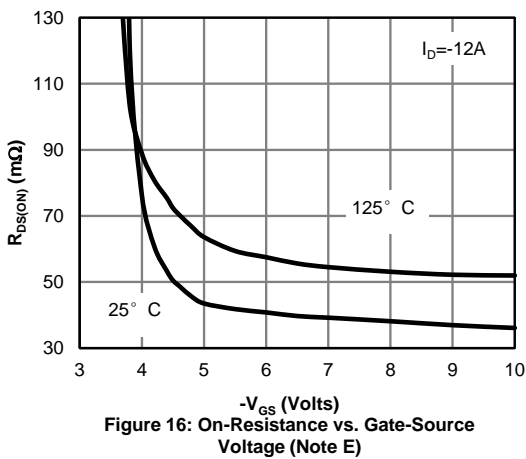


Figure 16: On-Resistance vs. Gate-Source Voltage (Note E)

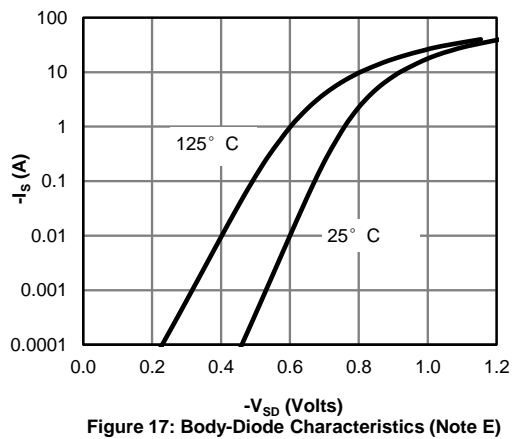


Figure 17: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

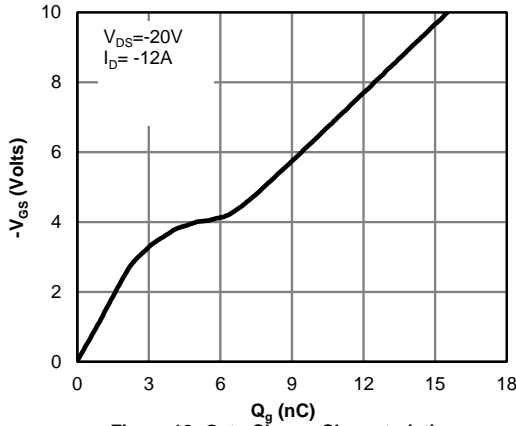


Figure 18: Gate-Charge Characteristics

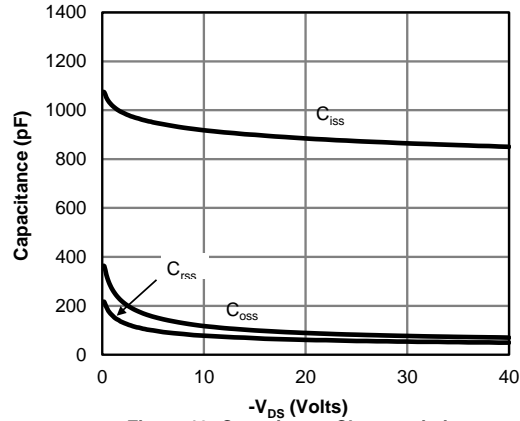


Figure 19: Capacitance Characteristics

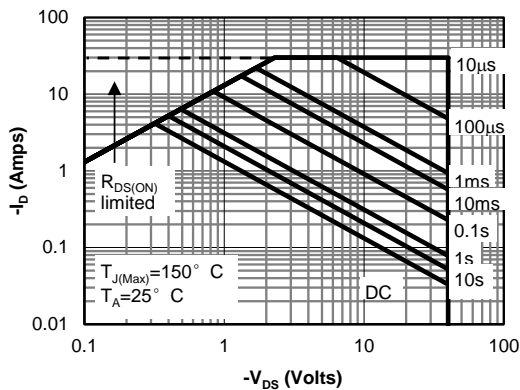


Figure 20: Maximum Forward Biased Safe Operating Area (Note F)

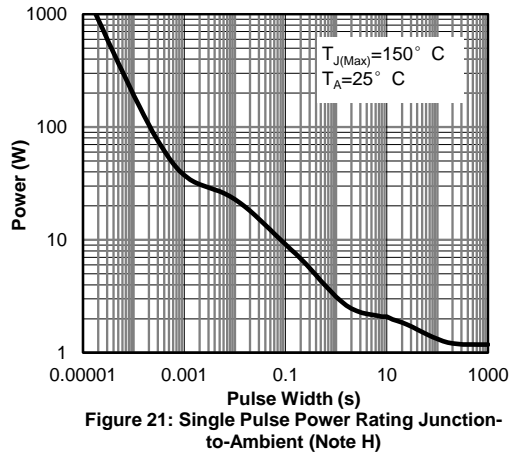


Figure 21: Single Pulse Power Rating Junction-to-Ambient (Note H)

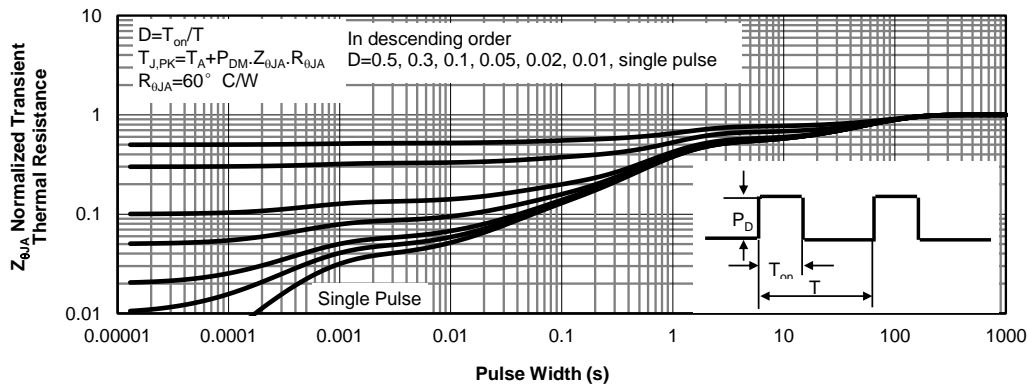
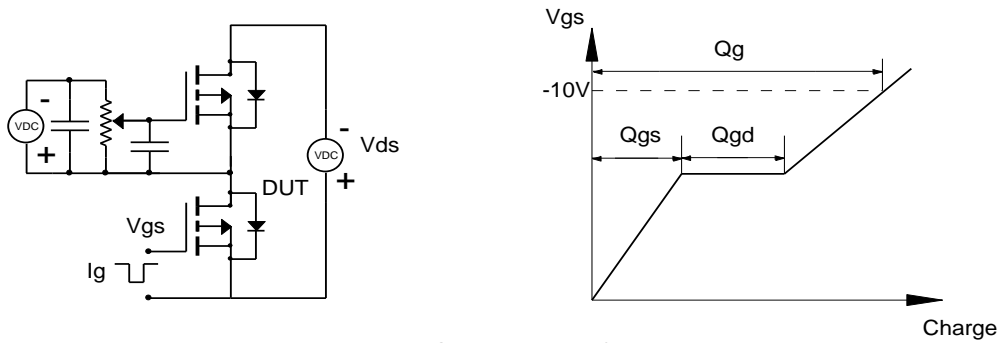


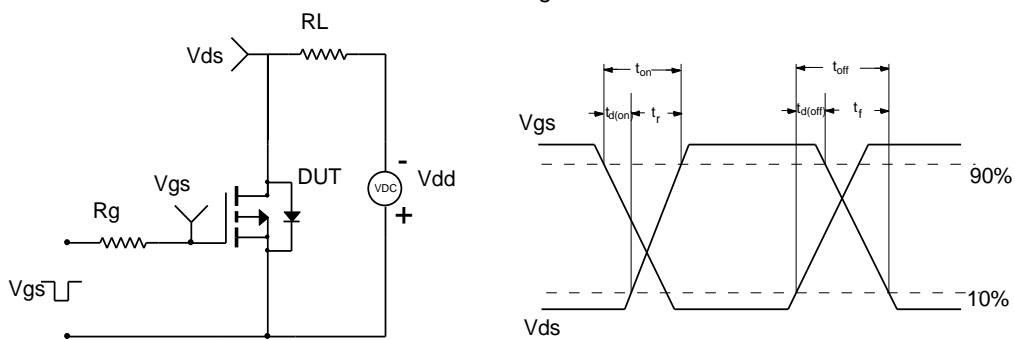
Figure 22: Normalized Maximum Transient Thermal Impedance (Note H)

TEST CIRCUITS AND WAVEFORMS: P-CHANNEL

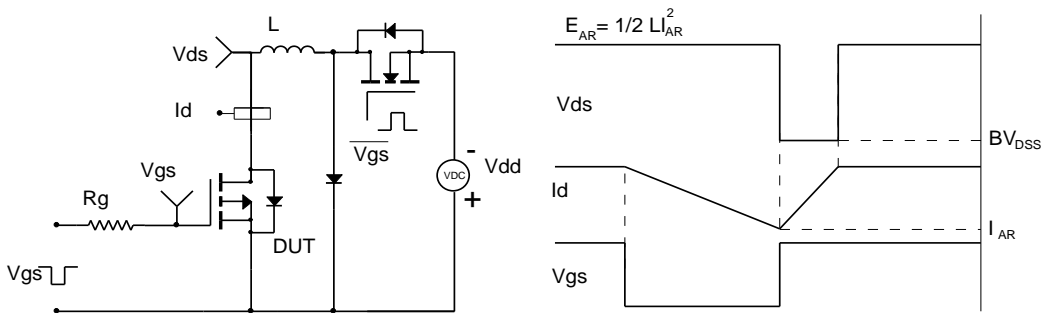
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

